49	11	((leadframe and (sink or spreader or	USPAT;	2004/08/17
		dissipating or heat) and ((cure or	EPO; JPO;	16:18
		curing) with epoxy)) and (@ad<19990831))	DERWENT;	
		and (encapsulants or encpasulate or	IBM_TDB	
1		((outer or second) near encapsulant))		
48	94	1 ,	USPAT;	2004/08/17
		dissipating or heat) and ((cure or	US-PGPUB;	16:32
		curing) with epoxy)) and (@ad<19990831)	EPO; JPO;	
			DERWENT;	
1			IBM_TDB	
50	154	· · · · · · · · · · · · · · · · · · ·	USPAT;	2004/08/17
		(sink or spreader or heat or dissipating)	US-PGPUB;	17:31
Ì			EPO; JPO;	
			DERWENT;	
		(057/700) 1 (0) (0 000001)	IBM_TDB	
51	26	1 , ,	USPAT;	2004/08/17
		(sink or spreader or heat or	US-PGPUB;	16:34
		dissipating)) and ((cure or curing or	EPO; JPO;	
		cured or solidify or solid or hardened)	DERWENT;	
1.0		with epoxy)	IBM_TDB	0004/00/15
52	31		USPAT;	2004/08/17
		and ((sink or spreader or heat or	US-PGPUB;	17:33
1		dissipating) with (plate or substrate))	EPO; JPO;	
		and (encapsulant or encapsulate)	DERWENT;	!
53	1	/	IBM_TDB	
53	46	' 2 3 ' ' - - - - - - - -	USPAT;	2004/08/17
		(@ad<19990831) and ((sink or spreader or	US-PGPUB;	17:48
		heat or dissipating) with (plate or	EPO; JPO;	
		substrate)) and (encapsulant or	DERWENT;	
- 4	10	encapsulate)	IBM_TDB	
54	18		USPAT;	2004/08/17
1		and (@ad<19990831) and ((sink or spreader	US-PGPUB;	17:36
		or heat or dissipating) with (plate or	EPO; JPO;	
		substrate)) and (encapsulant or	DERWENT;	
		encapsulate)) and (epoxy with (cure or curing))	IBM_TDB	
55	116	1	MCDDM.	2004/00/17
33	116	(epoxy with (underfill or interface)) and	USPAT; US-PGPUB;	2004/08/17
1		(@ad<19990831) and (sink or spreader or heat or dissipating) and (encapsulant or	1	17:48
		encapsulate)	EPO; JPO; DERWENT;	
		encapsurate	IBM TDB	
56	116	((epoxy with (underfill or interface))	USPAT;	2004/08/17
	110	and (@ad<19990831) and (sink or spreader	US-PGPUB;	17:49
'	i	or heat or dissipating) and (encapsulant	EPO; JPO;	17.45
		or encapsulate)) and (@ad<19990831)	DERWENT;	
		or encapsulate,, and (eackly)	IBM TDB	
_	19	(((cure or harden or solidify) and	USPAT;	2004/08/16
	-	microwave and (sink or spreader or	US-PGPUB;	21:04
		dissipating or thermal or heat)) with	EPO; JPO;	
]	epoxy)	DERWENT;	
		-E 1 /	IBM TDB	
l –	37	(((cure or harden or solidify or curing)	USPAT;	2004/08/16
1	[and microwave and (sink or spreader or	US-PGPUB;	21:04
]	dissipating or thermal or heat)) with	EPO; JPO;	
]	epoxy)	DERWENT;	
			IBM TDB	
-	19	((((cure or harden or solidify or curing)	USPAT;	2004/08/16
		and microwave and (sink or spreader or	US-PGPUB;	21:23
		dissipating or thermal or heat)) with	EPO; JPO;	
i	1	epoxy)) and (@ad<19990831)	DERWENT;	
1		2,,	IBM TDB	
1 –	11	((((cure or harden or solidify or	USPAT;	2004/08/16
		curing) and microwave and (sink or	US-PGPUB;	21:09
		spreader or dissipating or thermal or	EPO; JPO;	
1		heat)) with epoxy)) and (@ad<19990831))	DERWENT;	i i
		and (chip or die or ic or circuit or	IBM TDB	
		semiconductor)		1
_	14	·	USPAT;	2004/08/16
	•••	heat or thermal or dissipating) with	US-PGPUB;	21:33
		epoxy) and (chip or die or ic or circuit	EPO; JPO;	
1		or semiconductor)	DERWENT;	1
1			IBM TDB	
				· ·

	T 8	361/701.ccls. and ((sink or spreader or	USPAT;	2004/08/16
	•	heat or thermal or dissipating) with	US-PGPUB;	21:18
		epoxy) and (chip or die or ic or circuit	EPO; JPO;	
		or semiconductor) and (@ad<19990831)	DERWENT;	
	_		IBM_TDB	
-	17		USPAT;	2004/08/16
]	heat or thermal or dissipating) with	US-PGPUB;	21:25
		epoxy) and (chip or die or ic or circuit or semiconductor) and (@ad<19990831)	EPO; JPO; DERWENT;	
		or semiconductor, and (ead<19990031)	IBM TDB	
_	17	(361/702.ccls. and ((sink or spreader or	USPAT;	2004/08/16
		heat or thermal or dissipating) with	US-PGPUB;	21:18
		epoxy) and (chip or die or ic or circuit	EPO; JPO;	
	ŀ	or semiconductor) and (@ad<19990831)) not	DERWENT;	
	į	(361/701.ccls. and ((sink or spreader or	IBM_TDB	
		heat or thermal or dissipating) with		
		epoxy) and (chip or die or ic or circuit or semiconductor) and (@ad<19990831))		
_	0		USPAT;	2004/08/16
		heat or thermal or dissipating) with	US-PGPUB;	21:22
		epoxy) and (chip or die or ic or circuit	EPO; JPO;	
		or semiconductor) and (@ad<19990831)) not	DERWENT;	·
		(361/701.ccls. and ((sink or spreader or	IBM_TDB	
		heat or thermal or dissipating) with		
		epoxy) and (chip or die or ic or circuit or semiconductor) and (@ad<19990831)))		
		and (((cure or curing) with epoxy) and	:	
		microwave)		
-	10		USPAT;	2004/08/16
		heat or thermal or dissipating) with	US-PGPUB;	21:31
		epoxy) and (chip or die or ic or circuit	EPO; JPO;	
		or semiconductor) and (@ad<19990831)	DERWENT;	
_	0	(361/703.ccls. and ((sink or spreader or	IBM_TDB USPAT;	2004/08/16
		heat or thermal or dissipating) with	US-PGPUB;	21:31
		epoxy) and (chip or die or ic or circuit	EPO; JPO;	22.31
		or semiconductor) and (@ad<19990831)) and	DERWENT;	
		(((cure or curing) with epoxy) and	IBM_TDB	
		microwave)		
-	1015	(((cure or curing) with epoxy) and microwave)	USPAT;	2004/08/16
		microwave)	US-PGPUB; EPO; JPO;	21:22
			DERWENT;	
			IBM TDB	
-	218	((((cure or curing) with epoxy) and	USPAT;	2004/08/16
		microwave)) and ((sink or spreader or	US-PGPUB;	21:23
		heat or thermal or dissipating) with	EPO; JPO;	
		epoxy) and (chip or die or ic or circuit or semiconductor)	DERWENT; IBM TDB	
-	110	l '	USPAT;	2004/08/16
		microwave)) and ((sink or spreader or	US-PGPUB;	21:40
		heat or thermal or dissipating) with	EPO; JPO;	
		epoxy) and (chip or die or ic or circuit	DERWENT;	
	6	or semiconductor)) and (@ad<19990831)	IBM_TDB	2004/00/16
-	6	((((((cure or curing) with epoxy) and microwave)) and ((sink or spreader or	USPAT; US-PGPUB;	2004/08/16 21:26
	ļ	heat or thermal or dissipating) with	EPO; JPO;	21:20
		epoxy) and (chip or die or ic or circuit	DERWENT;	
1		or semiconductor)) and (@ad<19990831))	IBM_TDB	
1		and ((sink or spreader or (heat near	_	
		dissipating) or (thermal near		
		(dissipating or element))) with epoxy)		
		and (chip or die or ic or circuit or semiconductor) and (@ad<19990831)		
-	129		USPAT;	2004/08/16
		heat or thermal or dissipating) with	US-PGPUB;	21:31
		epoxy) and (chip or die or ic or circuit	EPO; JPO;	
		or semiconductor) and (@ad<19990831)	DERWENT;	
			IBM TDB	

_	0	(361/704.ccls. and ((sink or spreader or heat or thermal or dissipating) with epoxy) and (chip or die or ic or circuit or semiconductor) and (@ad<19990831)) and (((cure or curing) with epoxy) and microwave)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/16 21:33
-	96	1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/16 21:34
_	0	(257/722.ccls. and ((sink or spreader or heat or thermal or dissipating) with epoxy) and (chip or die or ic or circuit or semiconductor)) and ((cure or curing) with epoxy) and microwave)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/16 21:34
-	189		USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/16 21:35
_	1	(257/707.ccls. and ((sink or spreader or heat or thermal or dissipating) with epoxy)) and (((cure or curing) with epoxy) and microwave)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/16 21:35
_	103	257/723.ccls. and ((sink or spreader or heat or thermal or dissipating) with epoxy)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/16 21:35
_	2	heat or thermal or dissipating) with epoxy)) and (((cure or curing) with epoxy) and microwave)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/16 21:36
_	92	257/704.ccls. and ((sink or spreader or heat or thermal or dissipating) with epoxy)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/16
-	1	(257/704.ccls. and ((sink or spreader or heat or thermal or dissipating) with epoxy)) and (((cure or curing) with epoxy) and microwave)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/16 21:36
-	38	257/705.ccls. and ((sink or spreader or heat or thermal or dissipating) with epoxy)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/16 21:36
-	0	(257/705.ccls. and ((sink or spreader or heat or thermal or dissipating) with epoxy)) and (((cure or curing) with epoxy) and microwave)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/16 21:40
	79	(((cure or curing) and microwave) with epoxy)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/16 21:40
-	44	((((cure or curing) and microwave) with epoxy)) and (@ad<19990831)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/17 15:08
-	1	("6764882").PN.	USPAT	2004/08/17 13:34

L	Hits	Search Text	DB	Time stamp
Number 33	44	((((cure or curing) and microwave) with	USPAT;	2004/08/17
		epoxy)) and (@ad<19990831)	US-PGPUB; EPO; JPO; DERWENT;	15:56
35	4	((((((cure or curing) and microwave) with epoxy)) and (@ad<19990831)) and (cure or curing) with microwave)) and (chip or die)	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2004/08/17 15:10
34	32	(((((cure or curing) and microwave) with epoxy)) and (@ad<19990831)) and ((cure or curing) with microwave)	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	2004/08/17 15:54
36	572	(Chip or die) and ((cure or curing) with (epoxy and (enhance or increase)))	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/17 15:55
37	572	((Chip or die) and ((cure or curing) with (epoxy and (enhance or increase)))) and ((cure or curing) with (enhance or increase))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/17 15:58
38	209	((Chip or die) and ((cure or curing) with (epoxy and (enhance or increase)))) and (epoxy with adhesive)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/17 15:56
40	99	(((Chip or die) and ((cure or curing) with (epoxy and (enhance or increase)))) and (epoxy with adhesive)) and (@ad<19990831)	USPAT; EPO; JPO; DERWENT; IBM TDB	2004/08/17 15:57
41	69	((((Chip or die) and ((cure or curing) with (epoxy and (enhance or increase)))) and (epoxy with adhesive)) and (@ad<19990831)) and ((cure or curing) with (bond or bonding or strength))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/17 16:02
42	704		USPAT; EPO; JPO; DERWENT;	2004/08/17 16:17
43	103		IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/17 17:49
44	103		USPĀT; US-PGPUB; EPO; JPO; DERWENT;	2004/08/17 16:34
45	96		IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/17 16:11
46	57	257/666.ccls. and (sink or spreader or dissipating or heat) and ((cure or curing) with epoxy)	USPĀT; US-PGPUB; EPO; JPO; DERWENT;	2004/08/17 16:16
47	183	leadframe and (sink or spreader or dissipating or heat) and ((cure or curing) with epoxy)	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2004/08/17

Fren cited Agen

DERWENT-ACC-NO:

1987-084066

DERWENT-WEEK:

198712

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TITLE:

Metallisation of ceramic for PCB of

IC - by baking mixt.

of copper cpd., silica, alumina with

zinc or zinc cpd. at

relatively low temp. and reducing

PATENT-ASSIGNEE: AGENCY OF IND SCI & TECHNOLOGY [AGEN]

PRIORITY-DATA: 1985JP-0176588 (August 9, 1985)

PATENT-FAMILY:

PUB-NO PUB-DATE LANGUAGE PAGES MAIN-IPC

JP 62036091 A February 17, 1987 N/A

004 N/A

JP 90032235 B July 19, 1990 N/A

000 N/A

APPLICATION-DATA:

PUB-NO APPL-DESCRIPTOR APPL-NO

APPL-DATE

JP 62036091A N/A

1985JP-0176588 August 9, 1985

JP 90032235B N/A

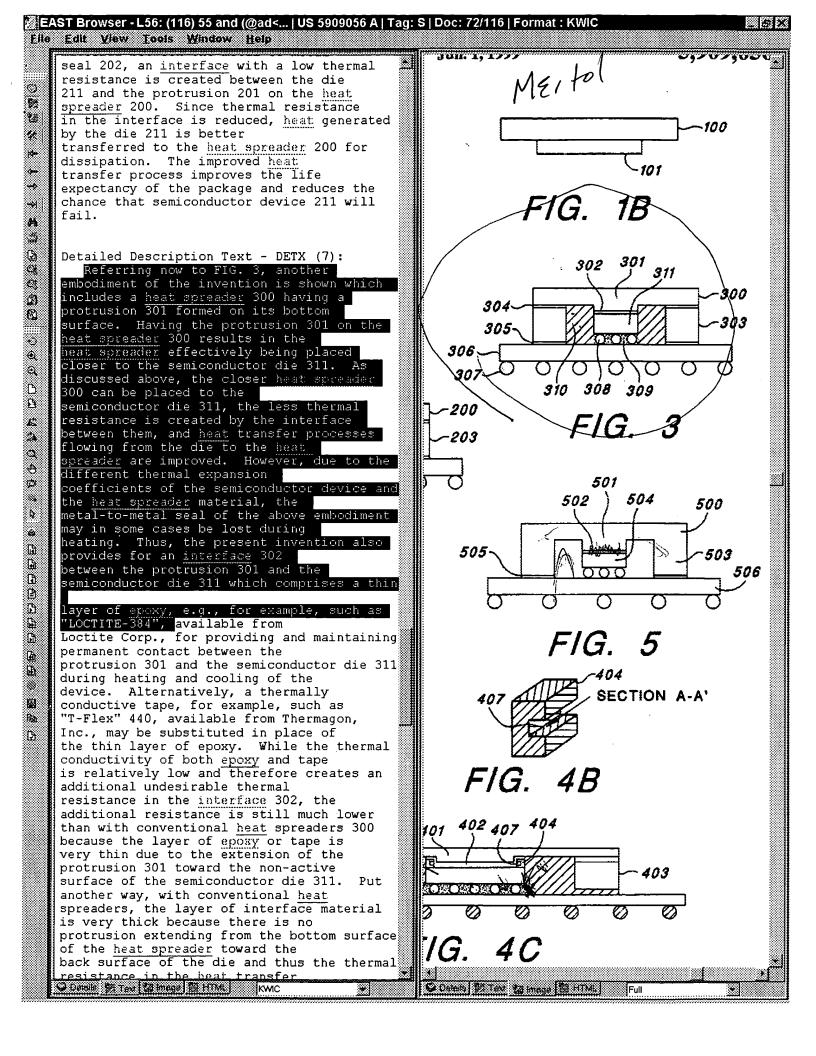
1985JP-0176588 August 9, 1985

INT-CL (IPC): C04B041/88

ABSTRACTED-PUB-NO: JP 62036091A

BASIC-ABSTRACT:

A mixt. consisting of at least one of CuCO3, CuSO4, CuS, CuO and CuCl2, at least one of SiO2 and kaolin, and at least one of Zn and Zn cpds. is coated on the surface of the ceramic, baking at 900-1300 deg.C in oxidising atmos., then reducing the baked layer.



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FIG. 2b by the use of an electrically nonconductive adhesive such as epoxy. The aluminum plate stiffens the resulting composite printed circuit board, and allows components to be mounted from the "component" side, whereby the "circuit" side (which as mentioned is the underside illustrated in FIGS. 1 and 2), may be passed through a standard wave soldering apparatus for low cost assembly. If desired, the components, such as component 26 illustrated in FIG. 1, may be clamped to the upper surface of aluminum plate 24 to enhance heat transfer away from the component toward a thermal sink (not illustrated). FIG. 3 illustrates a cross section through a component mounted on a composite printed circuit board such as that described in conjunction with FIGS. 1 and 2. In FIG. 3, elements corresponding to those of FIGS. 1 and 2 are designated by the same reference numerals. In FIG. 3, component 26 is illustrated in outline as a transistor, a mounting plate 49 of which is clamped against the upper surface of conductive plate 24 by a screw 50, which passes through mounting hole 32 and screws into a mounting post 52. Mounting post 52 bears against the lower side of ground plating 18. As also illustrated in FIG. 3, conductive plate 24 is mounted to the upper surface of ground plane 14 by means of a nonconductive epoxy 54. The thickness of epoxy 54 may vary, so that the lower surface of conductive plate 24 may make electrical contact with the upper surface of ground plane 14 at various points, such as point 56. Also, if any burrs remain from the drilling of holes 34 or 36, or 40 or 42, the burrs may penetrate through epoxy 54 to make contact. Even if epoxy 54 is rendered

conductive by the addition of a solid conductive filler such as silver

particles, the contact such as at point 56 will tend to change the impedance of the ground paths. Such uncontrolled ground plane connections may be disadvantageous as described in the aforementioned Meier article, and should be avoided in any manufacturing process making production quantities as opposed to one-of-a-kind items.

United States Patent 1191

(si) Patent Number: [45] Date of Patents

4,975,142 Dec. 4, 1990

Immscone et al.

[54] PARRICATION METHOD FOR PRINTED CIRCUIT BOARD

[75] Inventora: Joseph M. Impacone, Bonsalom, Pa.; Lawrence J. Inbesson, Mount Laurel,

[73] Assignou General Electric Company, Moorestown, N.J.

[21] Appl. No.: 433,066

1221: Filed: Nov. 7, 1989

1517 Test CD

317, 318; 361/395, 397, 430, 401, 403, 413; 204/13

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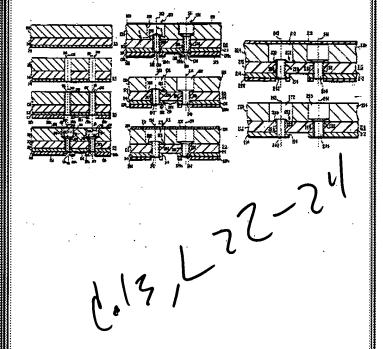
"Perioted Circuit Integration of MW Fidnes" by Rooney et al., published at pp. 2-6 of the Microwave Journal and distributed by Rugart Corporation.

"Microwave Stripline Packaging with VMDS" by Treat, published in Microwave Journal, Aug. 1975.

Primary Examinar—William A. Powell Attorney, Apart, or Firm—William H. Meise

ABSTRACT

A double-sided printed streat board includes a compo-neus side and a streat side. The foliatoric material is underirably lexible. To render the board rigid, the monutator bonded to the component side is a rigid plane. At locations at which plated-through component signal leads are to be standard, lest clearance nobe are defined. leads are to be stiaubind, lead clearance holes are defilled through all the way through the thin conductor, the disherate, and the plaze. The holes are piezed with con-ductor. From the exposed side of the place, larger holes are drilled caused with the clearance holes, part-way forcuph the plaze. The hold bottoms make an source angle with the same. The exposed surface are plazed with such resist. A second depth-controlled drilling with such resists. A second depth-controlled deficient occasis with the first is performed with a defil whoch he a reverse-single fixes, to a depth which entends almo-through the place, to thereby resource each resist in a sundar region succonditing the entired determine bod. The plate is exched sufficiently to free an extualar region The plate is exched sufficiently to free an ennalar region sround each electrones bels from conductor.



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that does not exceed 300° C.

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Dielectric encapsulant 130 may comprise a plastic encap-

sulant such as an epoxy with a high level of inorganic

particle fill (such as 70% silica) that is molded around device

102 and thermally cured (or cured with another process such

as UV light cure or microwave cure) to form a protective structure for the resultant device nackage 100 Particularly in

